

## N-Channel Enhancement Mode Power MOSFET

### **Description**

The MS8N60 is a N-channel enhancement-mode MOSFET, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost effectiveness. The TO-220 package is universally preferred for all commercial-industrial applications

#### **Features**

- · Low On Resistance
- · Simple Drive Requirement
- · Low Gate Charge
- · Fast Switching Characteristic
- · RoHS compliant package

#### **Application**

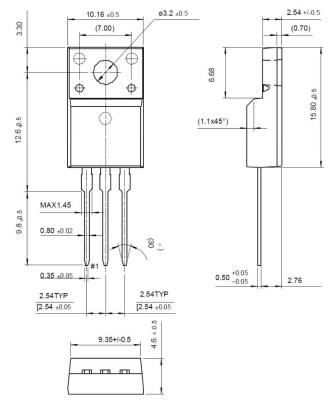
- Adapter
- Switching Mode Power Supply

### **Packing & Order Information**

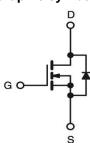
50/Tube; 1,000/Box







### **Graphic symbol**



### MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings						
Symbol	Parameter	Value	Unit			
$V_{DSS}$	Drain-Source Voltage	600	V			
$V_{GS}$	Gate-Source Voltage	±30	V			
I_	Drain Current -Continuous (TC=25°C)	7.5	A			
I <sub>D</sub>	Drain Current -Continuous (TC=100°C)	4.5	A			
$I_{DM}$	Drain Current Pulsed	30	A			
I <sub>AR</sub>	Avalanche Current	7.5	V			
E <sub>AS</sub>	Single Pulsed Avalanche Energy	230	mJ			
E <sub>AR</sub>	Repetitive Avalanche Energy	14.7	mJ			
dv/dt	Peak Diode Recovery dv/dt	4.5	V/ns			

Drain current limited by maximum junction temperature



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Absolute Maximum Ratings						
Symbol	Parameter	Value	Unit			
_	Maximum Temperature for Soldering @ Lead at 0.125	200	00			
TL	in(0.318mm) from case for 10 seconds	300	°C			
	Total Power Dissipation(@TC = 25 °C) 44 W	147	W			
$P_D$	Derating Factor above 25 °C	1.18	W/°C			
T <sub>STG</sub>	Operating and Storage Temperature	-55 to +150	°C			
T <sub>J</sub>	Storage Temperature	150	°C			

### Note:

- 1.Repetitive rating; pulse width limited by maximum junction temperature.
- 2.  $I_{AS} \le 7.5A$ ,  $V_{DD} = 50V$ , L=7.5mH,  $V_{G} = 10V$ , starting TJ=+25°C.
- 3. I<sub>SD</sub>≤7.5A, dI/dt≤200A/µs, VDD≤BVDSS, starting TJ=+25°C.

Thermal Characteristics						
Symbol Parameter		Min.	Тур.	Max.	Units	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case			0.85	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient			62.5	C/VV	

Static ChaStatic Characteristics						
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units
D\/	Drain-Source Breakdown	$V_{GS} = 0 \ V$ , $I_{D} = 250 \mu A$	600			V
$BV_{DSS}$	Voltage	Tj = 150°C		650		V
$\Delta BV_{DSS}$	Breakdown Voltage	1 050 A Defended to 0500	0.65			
$/\Delta T_{J}$	Temperature Coefficient	I <sub>D</sub> = 250μA, Referenced to 25°C		0.65		V/°C
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \text{ uA}$	2.0		4.0	V
I	Drain-Source Leakage	$V_{DS} = 600 \text{ V}$ , $V_{GS} = 0 \text{ V}$			1	uA
I <sub>DSS</sub>	Current	$V_{DS} = 480 \text{ V}$ , $T_{C} = 125^{\circ}\text{C}$			10	
lass	Gate-Body Leakage,	$V_{GS} = \pm 30$			±100	nA
I <sub>GSS</sub>	Forward	VGS =				
Rayou	Static Drain-Source	$V_{GS} = 10 \text{ V}$ , $I_{D} = 3.75 \text{ V}$		1.08	1.2	Ω
R <sub>DS(ON)</sub>	On-state Resistance	VGS - 10 V , 1D - 3.73 V	1.08	1.00	1.2	\$2



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Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units
$Q_g$	Total Gate Charge			31.3		nC
Q <sub>gs</sub>	Gate-Source Charge	$V_{DD} = 300 \text{ V}, I_D = 6 \text{ A},$ $V_{GS} = 10 \text{ V}$		6.9		nC
$Q_{gd}$	Gate-Drain Charge (Miller Charge)	V <sub>GS</sub> = 10 V		14		nC
C <sub>ISS</sub>	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		1482		pF
Coss	Output Capacitance			121.7		pF
C <sub>RSS</sub>	Reverse Transfer Capacitance			14		pF
t <sub>d(on)</sub>	Turn-On Time	$V_{DS} = 300 \text{ V}, I_{D} = 6 \text{ A},$ $V_{GS} = 10 \text{ V}, R_{G} = 10 \Omega$		14.2		ns
t <sub>r</sub>	Rise Time			11.8		ns
t <sub>d(off)</sub>	Turn-Off Delay Time			40.1		ns
tf	Fall Time			18.8		ns

Source-Drain Diode						
Symbol	Parameter	Test Conditions	Min	Тур.	Max.	Units
I <sub>S</sub>		$V_D = V_G = 0$ ,			7.5	_
I <sub>SM</sub>		V <sub>S</sub> = 1.3 V			30	A
V <sub>SD</sub>		$I_S = 7.5 \text{ A}$ , $V_{GS} = 0 \text{ V}$			1.5	V
t <sub>rr</sub>		$I_{F} = 6 \text{ A}$ , $V_{GS} = 0 \text{ V}$		504.9		ns
Q <sub>rr</sub>		diF/dt=100A/µs		47.59		uC

<sup>\*</sup>Pulse Test : Pulse Width ≤300µs, Duty Cycle≤2%



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